

TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

**TA78L05F, TA78L06F, TA78L07F, TA78L08F, TA78L09F, TA78L10F,
TA78L12F, TA78L15F, TA78L18F, TA78L20F, TA78L24F**

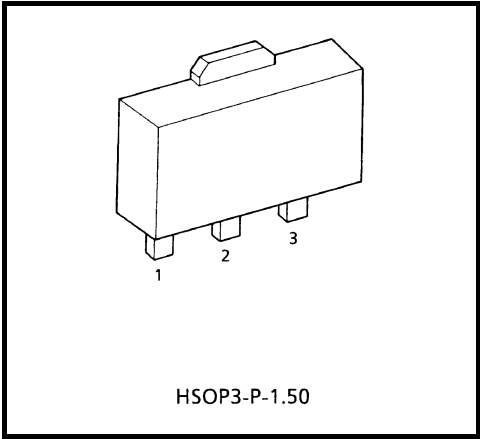
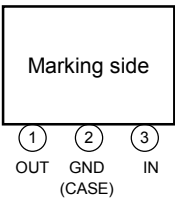
5 V, 6 V, 7 V, 8 V, 9 V, 10 V, 12 V, 15 V, 18 V, 20 V, 24 V

3-Terminal Positive Voltage Regulators

Features

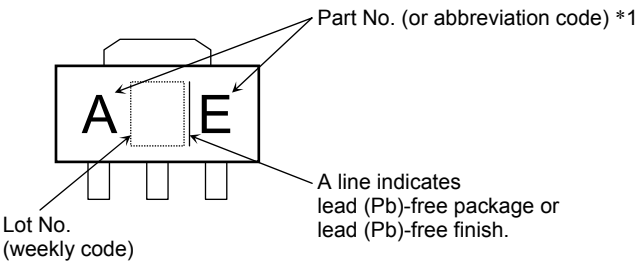
- Best suited to power supply for TTL/CMOS.
- No external parts needed.
- Built-in thermal protective circuit.
- Built-in short-circuit current limiting.
- Max output current of 150mA. ($T_j = 25^{\circ}\text{C}$).
- Packaged in POWER MINI (SOT-89).

Pin Assignment



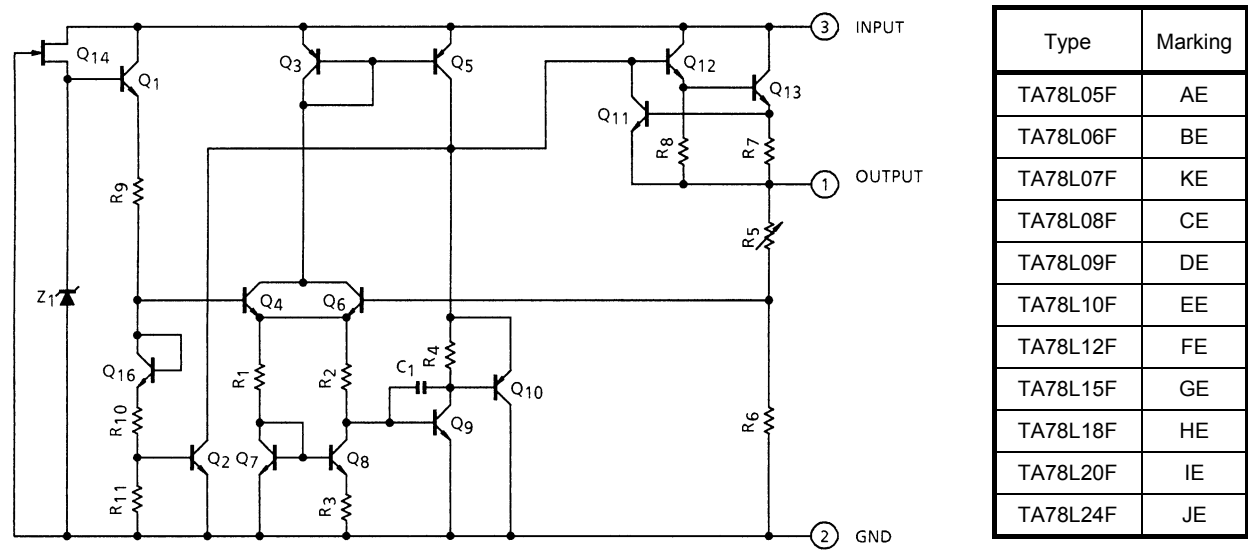
Weight: 0.05 g (Typ.)

Marking



*1	Part No. (or abbreviation code)	Part No.
	AE	TA78L05F
	BE	TA78L06F
	KE	TA78L07F
	CE	TA78L08F
	DE	TA78L09F
	EE	TA78L10F
	FE	TA78L12F
	GE	TA78L15F
	HE	TA78L18F
	IE	TA78L20F
	JE	TA78L24F

Equivalent Circuit



Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Input voltage	TA78L05F	V _{IN}	35	V
	TA78L06F			
	TA78L07F			
	TA78L08F			
	TA78L09F			
	TA78L10F			
	TA78L12F			
	TA78L15F			
	TA78L18F		40	
	TA78L20F			
	TA78L24F			
Power dissipation	(Ta = 25°C)	P _D	500	mW
Power dissipation		P _D	500	mW
Operating temperature		T _{opr}	-30~85	°C
Storage temperature		T _{stg}	-55~150	°C
Junction temperature		T _j	150	°C
Thermal resistance		R _{th (j-a)}	250	°C/W

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

TA78L05F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 10\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Output voltage	V_{OUT}	1	$T_j = 25^\circ\text{C}$	4.75	5.0	5.25	V
Line regulation	Reg·line	1	$T_j = 25^\circ\text{C}$	—	55	150	mV
			$7.0\text{ V} \leq V_{IN} \leq 20\text{ V}$	—	45	100	
Load regulation	Reg·load	1	$T_j = 25^\circ\text{C}$	—	11	60	mV
			$1.0\text{ mA} \leq I_{OUT} \leq 100\text{ mA}$	—	5.0	30	
Output voltage	V_{OUT}	1	$T_j = 25^\circ\text{C}$	4.65	—	5.35	V
			$7.0\text{ V} \leq V_{IN} \leq 20\text{ V}$, $1.0\text{ mA} \leq I_{OUT} \leq 40\text{ mA}$	4.65	—	5.35	
Quiescent current	I_B	1	$T_j = 25^\circ\text{C}$	—	3.1	6.0	mA
			$T_j = 125^\circ\text{C}$	—	—	5.5	
Quiescent current change	ΔI_B	1	$T_j = 25^\circ\text{C}$	—	—	1.5	mA
			$8.0\text{ V} \leq V_{IN} \leq 20\text{ V}$	—	—	0.1	
Output noise voltage	V_{NO}	2	$T_a = 25^\circ\text{C}$, $10\text{ Hz} \leq f \leq 100\text{ kHz}$	—	40	—	μV_{rms}
Long term stability	$\Delta V_{OUT}/\Delta t$	1	—	—	12	—	mV/kh
Ripple rejection ratio	R.R.	3	$f = 120\text{ Hz}$, $8.0\text{ V} \leq V_{IN} \leq 18\text{ V}$, $T_j = 25^\circ\text{C}$	41	49	—	dB
Dropout voltage	V_D	1	$T_j = 25^\circ\text{C}$, $I_{OUT} = 150\text{ mA}$	—	1.7	—	V
Average temperature coefficient of output voltage	T_{CVO}	1	$I_{OUT} = 5\text{ mA}$	—	-0.6	—	mV/ $^\circ\text{C}$

TA78L06F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 11\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		5.7	6.0	6.3	V
Line regulation	Reg·line	1	T _j = 25°C	8.1 V ≤ V _{IN} ≤ 21 V	—	50	150	mV
				9.0 V ≤ V _{IN} ≤ 21 V	—	45	110	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	12	70	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	5.5	35	
Output voltage	V _{OUT}	1	T _j = 25°C	8.1 V ≤ V _{IN} ≤ 21 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	5.58	—	6.42	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	5.58	—	6.42	
Quiescent current	I _B	1	T _j = 25°C		—	3.1	6.0	mA
			T _j = 125°C		—	—	5.5	
Quiescent current change	ΔI _B	1	T _j = 25°C	9.0 V ≤ V _{IN} ≤ 20 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	40	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	14	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 9.0 V ≤ V _{IN} ≤ 19 V, T _j = 25°C		39	47	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−0.7	—	mV/°C

TA78L07F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 12\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		6.65	7.0	7.35	V
Line regulation	Reg.line	1	T _j = 25°C	9.2 V ≤ V _{IN} ≤ 22 V	—	50	160	mV
				10 V ≤ V _{IN} ≤ 22 V	—	45	115	
Load regulation	Reg.load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	13	75	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	6.0	40	
Output voltage	V _{OUT}	1	T _j = 25°C	9.2 V ≤ V _{IN} ≤ 22 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	6.51	—	7.49	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	6.51	—	7.49	
Quiescent current	I _B	1	T _j = 25°C		—	3.1	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	10 V ≤ V _{IN} ≤ 22 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	50	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	17	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 10 V ≤ V _{IN} ≤ 20 V, T _j = 25°C		37	46	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−0.75	—	mV/°C

TA78L08F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 14\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		7.6	8.0	8.4	V
Line regulation	Reg·line	1	T _j = 25°C	10.5 V ≤ V _{IN} ≤ 23 V	—	20	175	mV
				11 V ≤ V _{IN} ≤ 23 V	—	12	125	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	15	80	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	7.0	40	
Output voltage	V _{OUT}	1	T _j = 25°C	10.5 V ≤ V _{IN} ≤ 23 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	7.44	—	8.56	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	7.44	—	8.56	
Quiescent current	I _B	1	T _j = 25°C		—	3.1	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	11 V ≤ V _{IN} ≤ 23 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	60	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	20	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 12 V ≤ V _{IN} ≤ 23 V, T _j = 25°C		37	45	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−0.8	—	mV/°C

TA78L09F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 15\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		8.55	9.0	9.45	V
Line regulation	Reg·line	1	T _j = 25°C	11.4 V ≤ V _{IN} ≤ 24 V	—	80	200	mV
				12 V ≤ V _{IN} ≤ 24 V	—	20	160	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	17	90	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	8.0	45	
Output voltage	V _{OUT}	1	T _j = 25°C	11.4 V ≤ V _{IN} ≤ 24 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	8.37	—	9.63	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	8.37	—	9.63	
Quiescent current	I _B	1	T _j = 25°C		—	3.2	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	12 V ≤ V _{IN} ≤ 24 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	65	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	21	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 12 V ≤ V _{IN} ≤ 24 V, T _j = 25°C		36	44	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−0.85	—	mV/°C

TA78L10F
Electrical Characteristics

 (Unless otherwise specified, $V_{IN} = 16\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		9.5	10	10.5	V
Line regulation	Reg·line	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 25 V	—	80	230	mV
				13 V ≤ V _{IN} ≤ 25 V	—	30	170	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	18	90	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	8.5	45	
Output voltage	V _{OUT}	1	T _j = 25°C	12.5 V ≤ V _{IN} ≤ 25 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	9.3	—	10.7	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	9.3	—	10.7	
Quiescent current	I _B	1	T _j = 25°C		—	3.2	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	13 V ≤ V _{IN} ≤ 25 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	Ta = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	70	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	22	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 13 V ≤ V _{IN} ≤ 24 V, T _j = 25°C		36	43	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−0.9	—	mV/°C

TA78L12F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 19\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		11.4	12	12.6	V
Line regulation	Reg.line	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 27 V	—	120	250	mV
				16 V ≤ V _{IN} ≤ 27 V	—	100	200	
Load regulation	Reg.load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	20	100	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	10	50	
Output voltage	V _{OUT}	1	T _j = 25°C	14.5 V ≤ V _{IN} ≤ 27 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	11.16	—	12.84	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	11.16	—	12.84	
Quiescent current	I _B	1	T _j = 25°C		—	3.2	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	16 V ≤ V _{IN} ≤ 27 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	80	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	24	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 15 V ≤ V _{IN} ≤ 25 V, T _j = 25°C		36	41	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−1.0	—	mV/°C

TA78L15F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 23\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		14.25	15	15.75	V
Line regulation	Reg·line	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V	—	130	300	mV
				20 V ≤ V _{IN} ≤ 30 V	—	110	250	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	25	150	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	12	75	
Output voltage	V _{OUT}	1	T _j = 25°C	17.5 V ≤ V _{IN} ≤ 30 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	13.95	—	16.05	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	13.95	—	16.05	
Quiescent current	I _B	1	T _j = 25°C		—	3.3	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	20 V ≤ V _{IN} ≤ 30 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	90	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	30	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 18.5 V ≤ V _{IN} ≤ 28.5 V, T _j = 25°C		34	40	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	-1.3	—	mV/°C

TA78L18F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 27\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		17.1	18	18.9	V
Line regulation	Reg·line	1	T _j = 25°C	21.4 V ≤ V _{IN} ≤ 33 V	—	32	325	mV
				22 V ≤ V _{IN} ≤ 33 V	—	27	275	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	30	170	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	15	75	
Output voltage	V _{OUT}	1	T _j = 25°C	21.4 V ≤ V _{IN} ≤ 33 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	16.74	—	19.26	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	16.74	—	19.26	
Quiescent current	I _B	1	T _j = 25°C		—	3.3	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	22 V ≤ V _{IN} ≤ 33 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	150	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	45	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 23 V ≤ V _{IN} ≤ 33 V, T _j = 25°C		32	38	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	−1.5	—	mV/°C

TA78L20F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 29\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

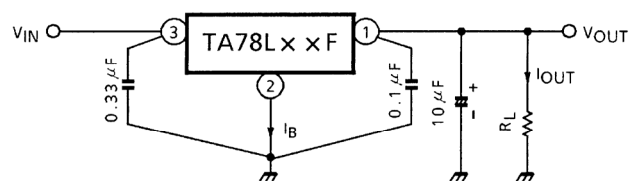
Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		19.0	20	21.0	V
Line regulation	Reg-line	1	T _j = 25°C	23.5 V ≤ V _{IN} ≤ 35 V	—	33	330	mV
				24 V ≤ V _{IN} ≤ 35 V	—	28	285	
Load regulation	Reg-load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	33	180	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	17	90	
Output voltage	V _{OUT}	1	T _j = 25°C	23.5 V ≤ V _{IN} ≤ 35 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	18.6	—	21.4	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	18.6	—	21.4	
Quiescent current	I _B	1	T _j = 25°C		—	3.3	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	24 V ≤ V _{IN} ≤ 35 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	170	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	49	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 25 V ≤ V _{IN} ≤ 35 V, T _j = 25°C		31	37	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	-1.7	—	mV/°C

TA78L24F
Electrical Characteristics

(Unless otherwise specified, $V_{IN} = 33\text{ V}$, $I_{OUT} = 40\text{ mA}$, $C_{IN} = 0.33\text{ }\mu\text{F}$, $C_{OUT} = 0.1\text{ }\mu\text{F}$, $0^\circ\text{C} \leq T_j \leq 125^\circ\text{C}$)

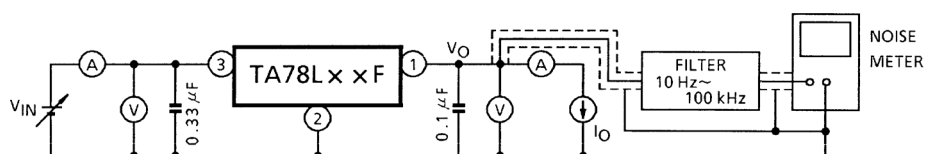
Characteristics	Symbol	Test Circuit	Test Condition		Min	Typ.	Max	Unit
Output voltage	V _{OUT}	1	T _j = 25°C		22.8	24	25.2	V
Line regulation	Reg·line	1	T _j = 25°C	27.5 V ≤ V _{IN} ≤ 38 V	—	35	350	mV
				28 V ≤ V _{IN} ≤ 38 V	—	30	300	
Load regulation	Reg·load	1	T _j = 25°C	1.0 mA ≤ I _{OUT} ≤ 100 mA	—	40	200	mV
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	20	100	
Output voltage	V _{OUT}	1	T _j = 25°C	27.5 V ≤ V _{IN} ≤ 38 V, 1.0 mA ≤ I _{OUT} ≤ 40 mA	22.32	—	25.68	V
				1.0 mA ≤ I _{OUT} ≤ 70 mA	22.32	—	25.68	
Quiescent current	I _B	1	T _j = 25°C		—	3.5	6.5	mA
			T _j = 125°C		—	—	6.0	
Quiescent current change	ΔI _B	1	T _j = 25°C	28 V ≤ V _{IN} ≤ 38 V	—	—	1.5	mA
				1.0 mA ≤ I _{OUT} ≤ 40 mA	—	—	0.1	
Output noise voltage	V _{NO}	2	T _a = 25°C, 10 Hz ≤ f ≤ 100 kHz		—	200	—	μV _{rms}
Long term stability	ΔV _{OUT} /Δt	1	—		—	56	—	mV/kh
Ripple rejection ratio	R.R.	3	f = 120 Hz, 29 V ≤ V _{IN} ≤ 39 V, T _j = 25°C		31	35	—	dB
Dropout voltage	V _D	1	T _j = 25°C, I _{OUT} = 150 mA		—	1.7	—	V
Average temperature coefficient of output voltage	T _{CVO}	1	I _{OUT} = 5 mA		—	-2.0	—	mV/°C

Test Circuit 1/Standard Application



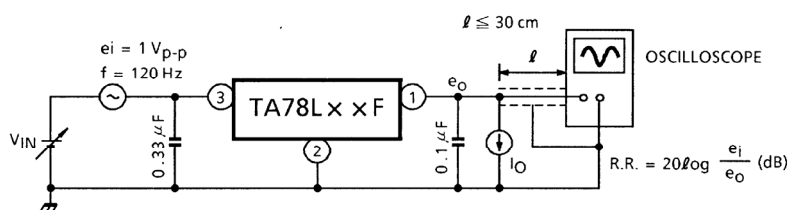
Test Circuit 2

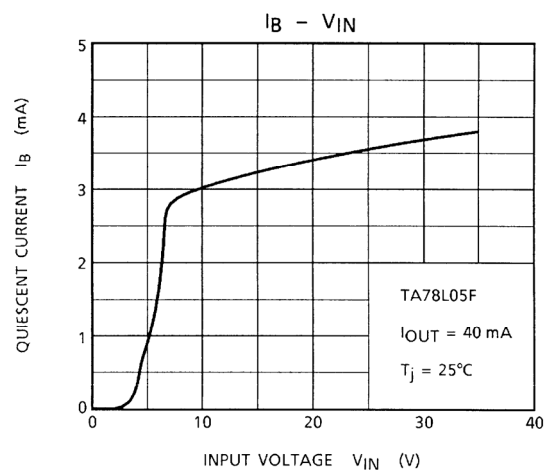
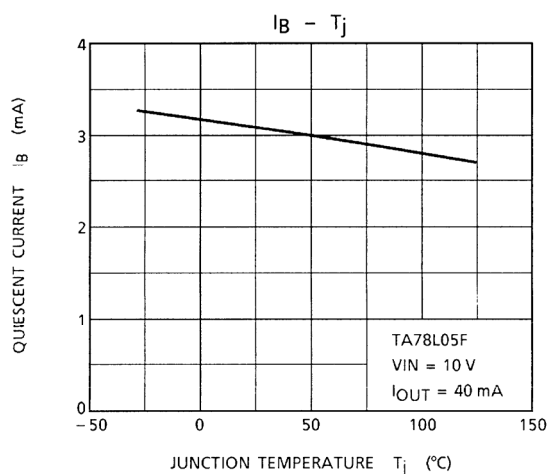
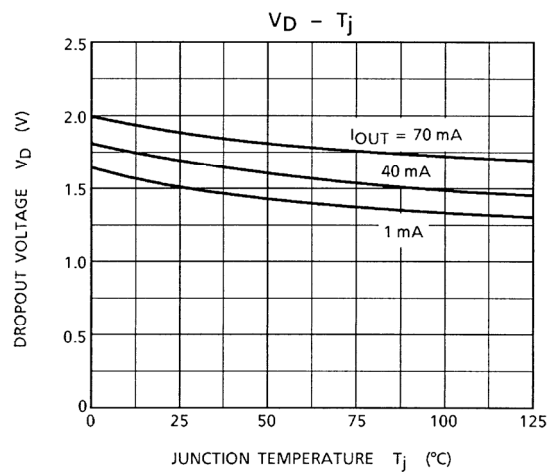
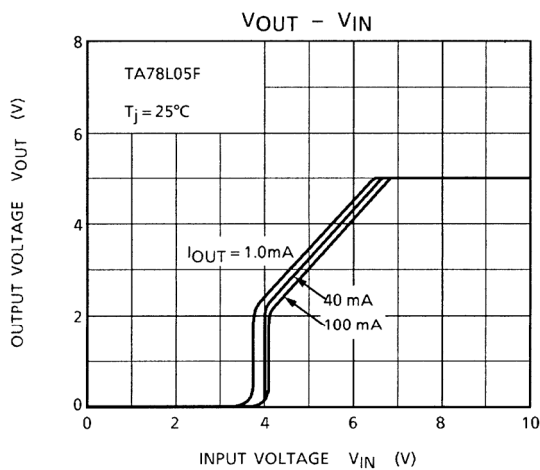
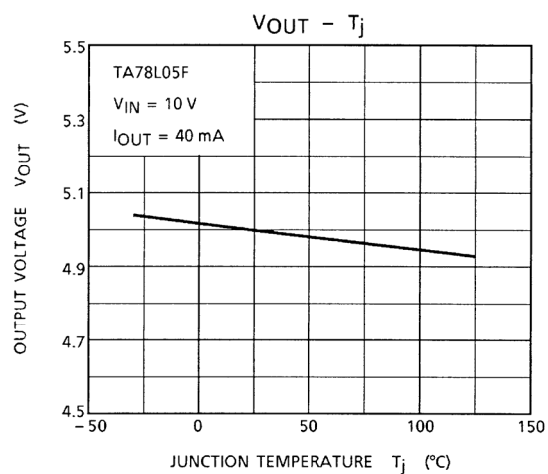
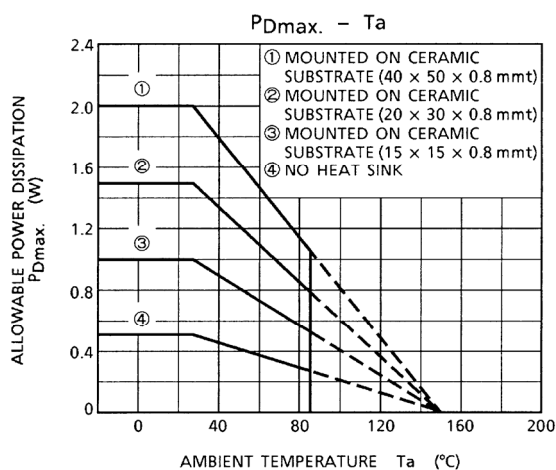
V_{NO}

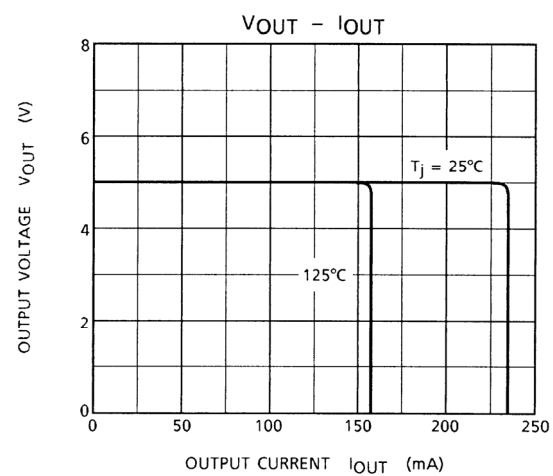
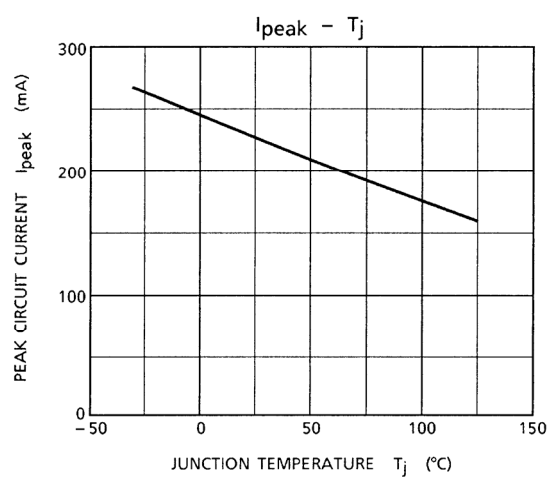


Test Circuit 3

R.R.





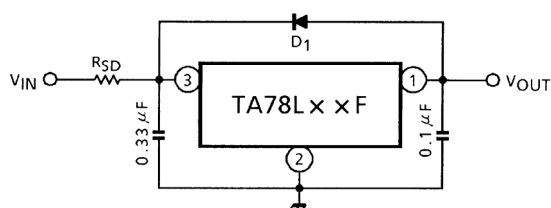


Precautions for Use

Destruction of the IC may occur if high voltage in excess of the IC output voltage (typ. value) is applied to the IC output terminal. Where this possibility exists, connect a Zener diode between the output terminal and GND to prevent any application of excessive voltage. In particular, in a current boosting circuit such as that shown in Application Circuit Example (2), if the input voltage is suddenly applied by stages and, furthermore, load is light, excessive voltage may be applied transiently to the output terminal of the IC. In such a case, it may become necessary to increase the capacity of the output capacitor as appropriate, use a smaller R_1 (a resistor for bypassing IC bias current) or gradually raise the input voltage, in addition to using a Zener diode as mentioned above.

Application Circuits

(1) Standard Application



D_1 : IC protective diode

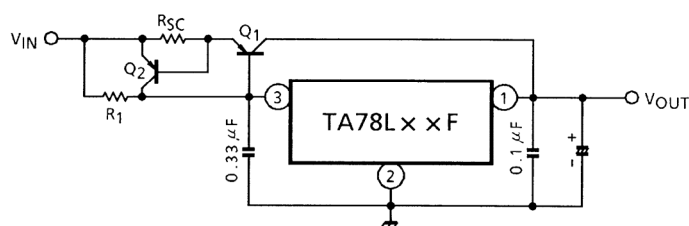
When surge voltage is applied to IC output terminal or $V_{IN} < V_{OUT}$ at the time of power ON/OFF, always connect the high speed switching diode D_1 .

R_{SD} : Power limiting resistor

If V_{IN} is too high, always connect R_{SD} in order to reduce power consumption of IC.

(2) A. Current Boost Voltage Regulator

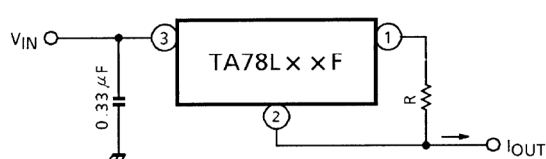
B. Short-Circuit Protection



$$R_{SC} = \frac{V_{BE2}}{I_{SC}}$$

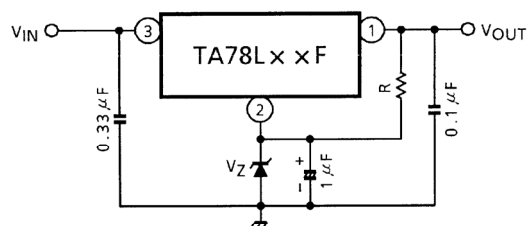
where, I_{SC} : Short-Circuit current

(3) Current Regulator

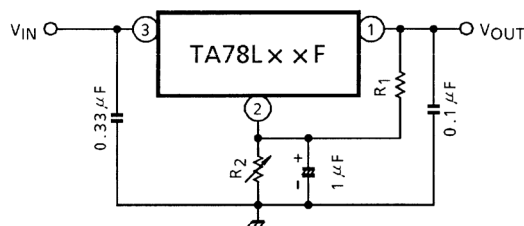


$$I_{OUT} = \frac{V_{OUT}}{R} + I_B$$

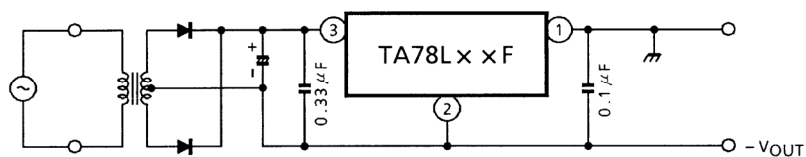
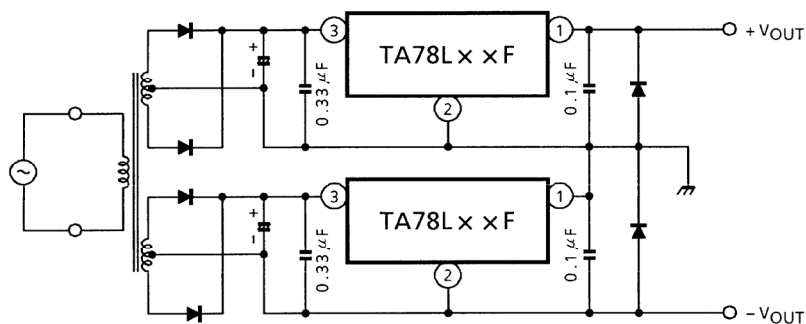
(4) Voltage Boost Regulator



$V_{OUT} = V_Z + V_{OUT} \text{ (of IC)}$
Apply current of several mA to R.



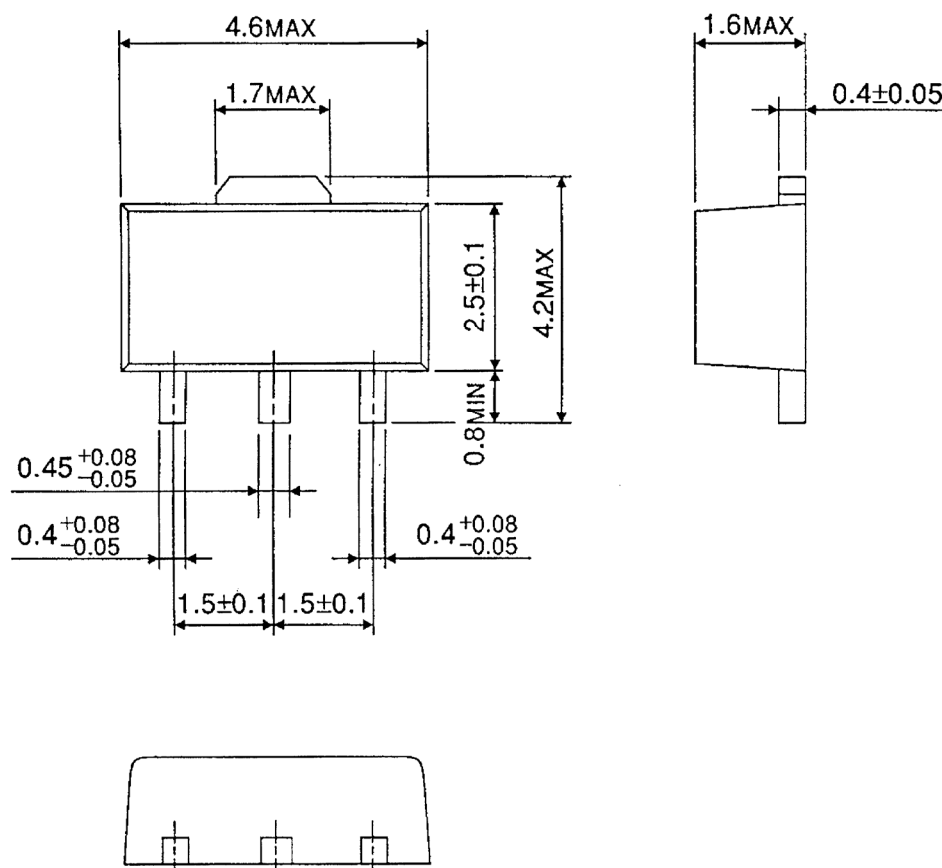
$$V_{OUT} = R_2 (I_B + \frac{V_{OUT} \text{ (of IC)}}{R_1}) + V_{OUT} \text{ (of IC)}$$

(5) Negative Regulator

(6) Positive and Negative Regulator


Package Dimensions

HSOP3-P-1.50

Unit : mm



Weight : 0.05 g (Typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN

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